

Vanadium Fine-Structure K-shell Electron Impact Ionization Cross Sections for Fast-Electron Diagnostic in Laser-Solid Experiments

P. Palmeri¹, P. Quinet^{1,2}, and D. Batani³

¹*Mécanique et Gravitation, Université de Mons – UMONS, B-7000 Mons, Belgium*

²*IPNAS, Université de Liège, B-4000 Liège, Belgium*

³*CELIA, Université de Bordeaux, F-33400 Talence, France*

Presenting Author: patrick.palmeri@umons.ac.be

The K-shell electron impact ionization (EII) cross section, along with the K-shell fluorescence yield, is one of the key atomic parameters for fast-electron diagnostic in laser-solid experiments through the K-shell emission cross section. In addition, in a campaign dedicated to the modeling of the K lines of astrophysical interest [1], the K-shell fluorescence yields for the K-vacancy fine-structure atomic levels of all the vanadium isonuclear ions have been calculated.

In this study, the K-shell EII cross sections connecting the ground and the metastable levels of the parent vanadium ions to the daughter ions K-vacancy levels considered in Ref. [1] have been determined. The relativistic distorted-wave (DW) approximation implemented in the FAC atomic code has been used for the incident electron kinetic energies up to 20 times the K-shell threshold energies. Moreover, the resulting DW cross sections have been extrapolated at higher energies using the asymptotic behavior of the modified relativistic binary encounter Bethe model (MRBEB) of Guerra *et al.* [2] with the density-effect correction proposed by Davies *et al.* [3].

References

- [1] P. Palmeri *et al.* *Astron. Astrophys.* **543**, A44 (2012)
- [2] M. Guerra *et al.* *Int. J. Mass Spectrom.* **313**, 1 (2012)
- [3] J. R. Davies *et al.*, *Phys. Plasmas* **20**, 083118 (2013)